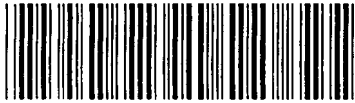


**Search Notes**

Application/Control No.

10/716,037

Examiner

Benjamin E. Lanier

Applicant(s)/Patent under  
Reexamination

BANTZ ET AL.

Art Unit

2132

**SEARCHED**

Class	Subclass	Date	Examiner
713	155	6/18/2007	<i>HL</i>
713	162	6/18/2007	<i>HL</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated Search of 726/22-25 713/188	6/19/2007	<i>HL</i>
EIC Fast & Focused Search See Attachment	6/20/2007	<i>HL</i>
Inventor Name Search Palm	6/20/2007	<i>HL</i>
Interference Search See Attachment	6/20/2007	<i>HL</i>